



**ALPHA & OMEGA**  
SEMICONDUCTOR

**AOD418/AOI418**

**30V N-Channel MOSFET**

### General Description

The AOD418/AOI418 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and low gate resistance. With the excellent thermal resistance of the DPAK/IPAK package, this device is well suited for high current load applications.

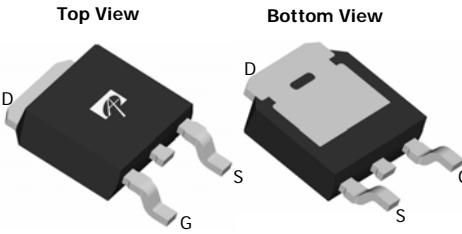
### Product Summary

$V_{DS}$	30V
$I_D$ (at $V_{GS} = 10V$ )	36A
$R_{DS(ON)}$ (at $V_{GS} = 10V$ )	< 7.5mΩ
$R_{DS(ON)}$ (at $V_{GS} = 4.5V$ )	< 11mΩ

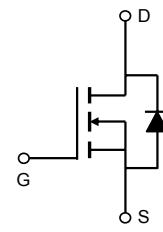
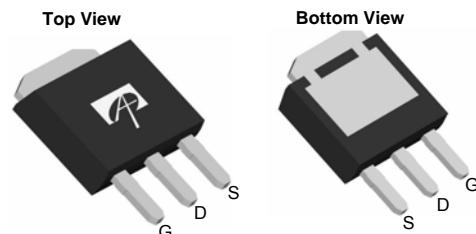
100% UIS Tested  
100%  $R_g$  Tested



TO252  
DPAK



TO251A  
IPAK



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current <sup>G</sup>	$I_D$	36	A
$T_C=100^\circ\text{C}$		28	
Pulsed Drain Current <sup>C</sup>	$I_{DM}$	125	
Continuous Drain Current	$I_{DSM}$	13.5	A
$T_A=70^\circ\text{C}$		10.5	
Avalanche Current <sup>C</sup>	$I_{AS}, I_{AR}$	27	A
Avalanche energy $L=0.1\text{mH}$ <sup>C</sup>	$E_{AS}, E_{AR}$	36	mJ
Power Dissipation <sup>B</sup>	$P_D$	50	W
$T_C=100^\circ\text{C}$		25	
Power Dissipation <sup>A</sup>	$P_{DSM}$	2.5	W
$T_A=70^\circ\text{C}$		1.6	
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 175	°C

### Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient <sup>A</sup>	$R_{0JA}$	16	20	°C/W
Maximum Junction-to-Ambient <sup>D</sup>		41	50	°C/W
Maximum Junction-to-Case	$R_{0JC}$	2.5	3	°C/W

Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	30			V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=30\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$			1	$\mu\text{A}$
					5	
$I_{GSS}$	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$			$\pm 100$	nA
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.5	1.95	2.5	V
$I_{D(\text{ON})}$	On state drain current	$V_{GS}=10\text{V}, V_{DS}=5\text{V}$	125			A
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=20\text{A}$ TO252 $T_J=125^\circ\text{C}$		6.2	7.5	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=20\text{A}$ TO252		9.5	11.5	
		$V_{GS}=10\text{V}, I_D=20\text{A}$ TO251A		8.5	11	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=20\text{A}$ TO251A		6.7	8	$\text{m}\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS}=5\text{V}, I_D=20\text{A}$		63		S
$V_{SD}$	Diode Forward Voltage	$I_S=1\text{A}, V_{GS}=0\text{V}$		0.72	1	V
$I_S$	Maximum Body-Diode Continuous Current <sup>G</sup>				36	A
<b>DYNAMIC PARAMETERS</b>						
$C_{iss}$	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=15\text{V}, f=1\text{MHz}$	920	1150	1380	pF
$C_{oss}$	Output Capacitance		125	180	235	pF
$C_{rss}$	Reverse Transfer Capacitance		60	105	150	pF
$R_g$	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$	0.55	1.1	1.65	$\Omega$
<b>SWITCHING PARAMETERS</b>						
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=10\text{V}, V_{DS}=15\text{V}, I_D=20\text{A}$	16	20	24	nC
$Q_g(4.5\text{V})$	Total Gate Charge		7.6	9.5	11	
$Q_{gs}$	Gate Source Charge			2.7		nC
$Q_{gd}$	Gate Drain Charge			5		nC
$t_{D(\text{on})}$	Turn-On DelayTime	$V_{GS}=10\text{V}, V_{DS}=15\text{V}, R_L=0.75\Omega, R_{GEN}=3\Omega$		6.5		ns
$t_r$	Turn-On Rise Time			2		ns
$t_{D(\text{off})}$	Turn-Off DelayTime			17		ns
$t_f$	Turn-Off Fall Time			3.5		ns
$t_{rr}$	Body Diode Reverse Recovery Time	$I_F=20\text{A}, dI/dt=500\text{A}/\mu\text{s}$	7	8.7	10.5	ns
$Q_{rr}$	Body Diode Reverse Recovery Charge	$I_F=20\text{A}, dI/dt=500\text{A}/\mu\text{s}$	11	13.5	16	nC

A. The value of  $R_{iJA}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{DSM}$  is based on  $R_{iJA}$  and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

B. The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=175^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(\text{MAX})}=175^\circ\text{C}$ . Ratings are based on low frequency and duty cycles to keep initial  $T=25^\circ\text{C}$ .

D. The  $R_{iJA}$  is the sum of the thermal impedance from junction to case  $R_{iJC}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(\text{MAX})}=175^\circ\text{C}$ . The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ .

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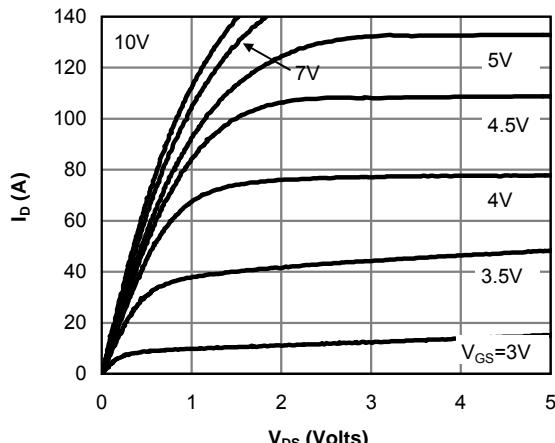
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**


Fig 1: On-Region Characteristics (Note E)

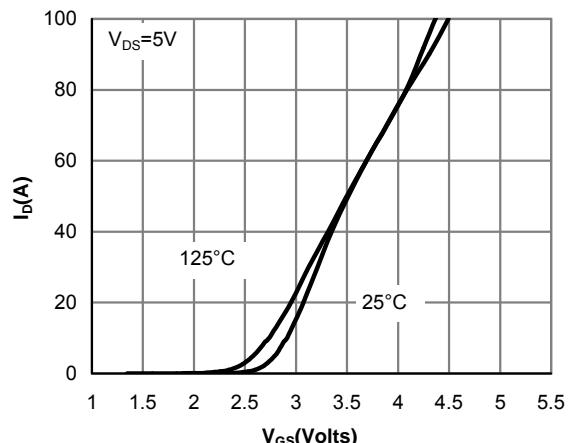


Figure 2: Transfer Characteristics (Note E)

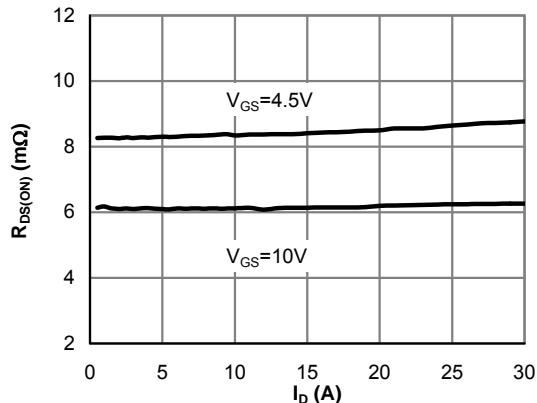


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

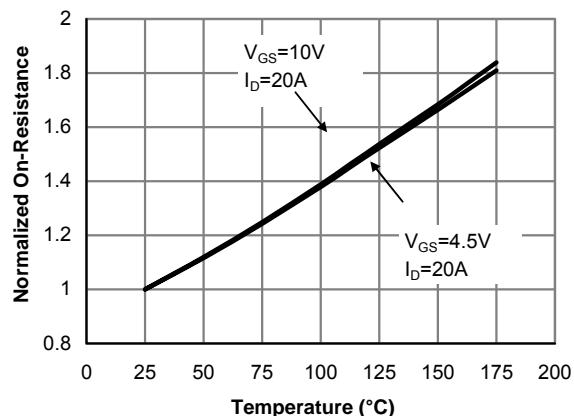


Figure 4: On-Resistance vs. Junction Temperature (Note E)

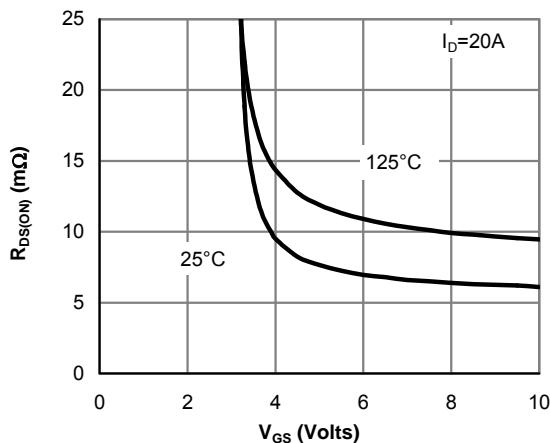


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

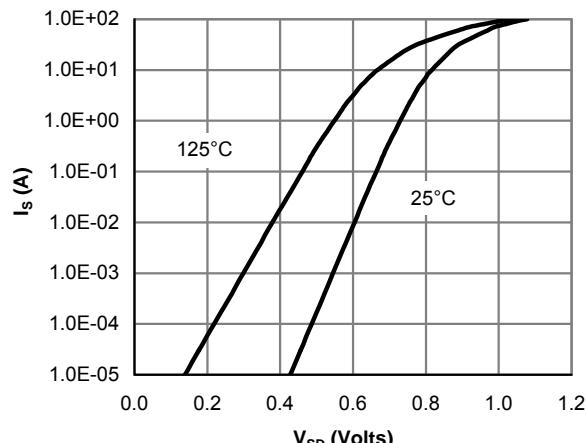


Figure 6: Body-Diode Characteristics (Note E)

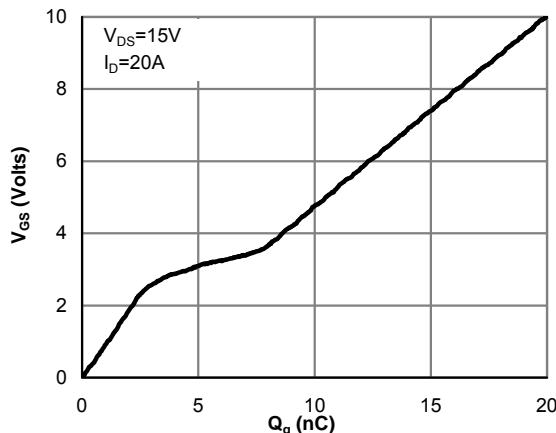
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**


Figure 7: Gate-Charge Characteristics

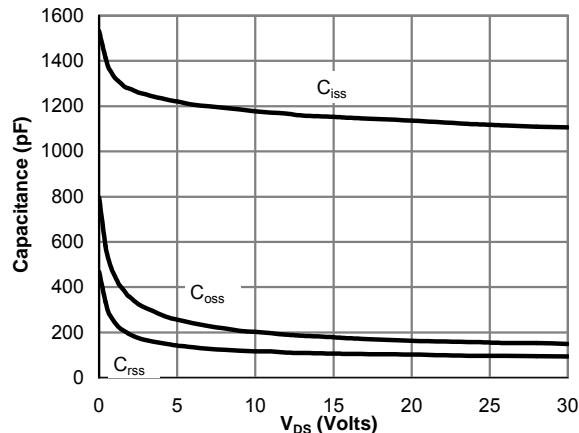


Figure 8: Capacitance Characteristics

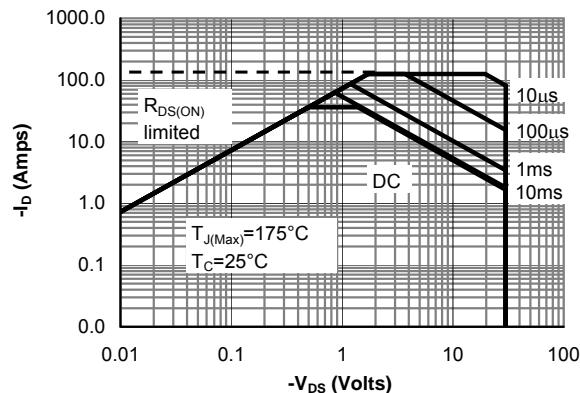


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

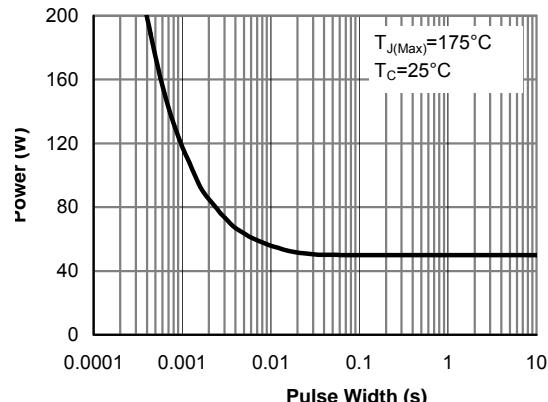


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

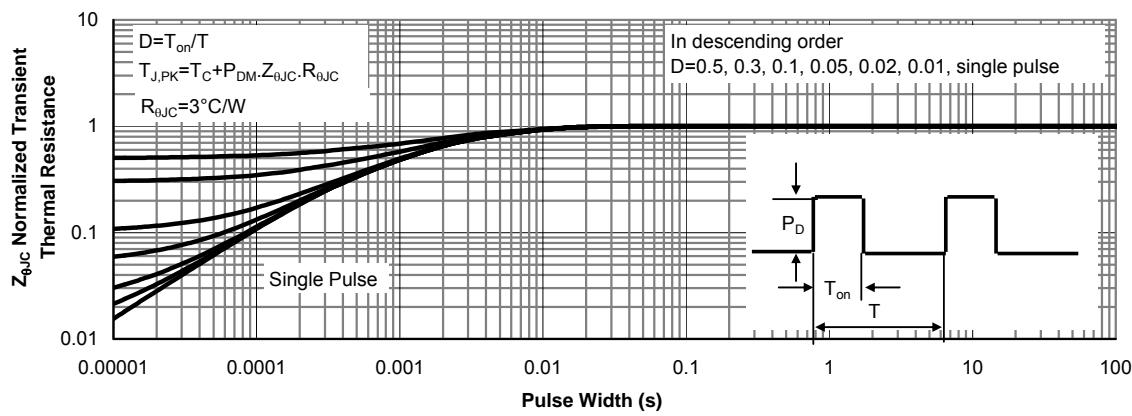
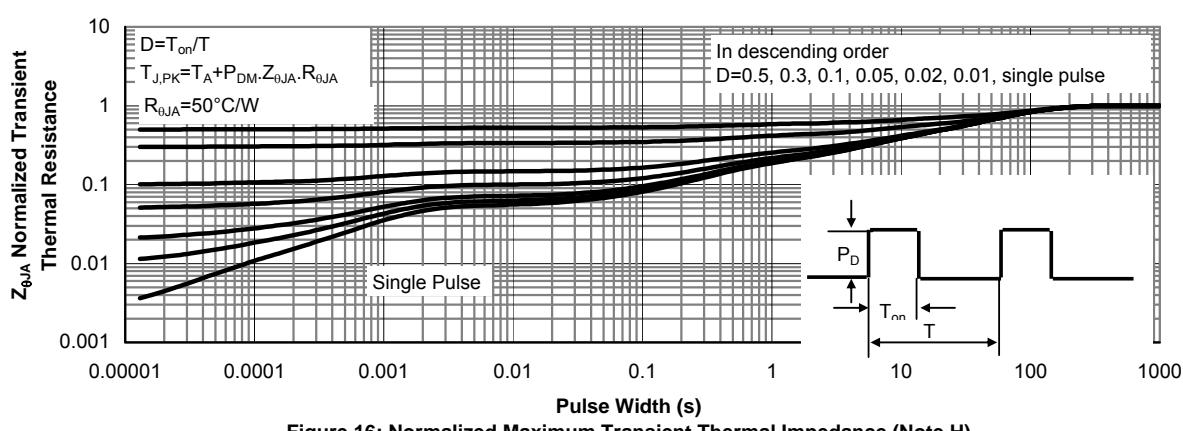
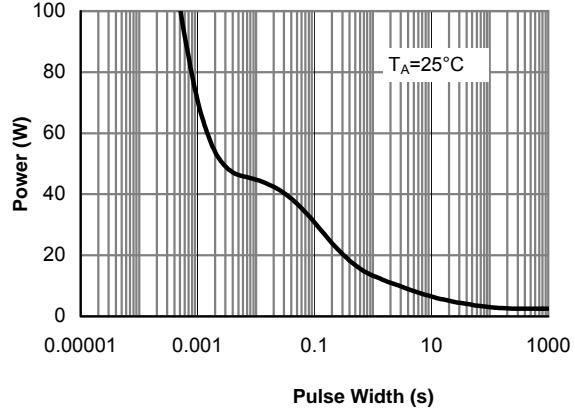
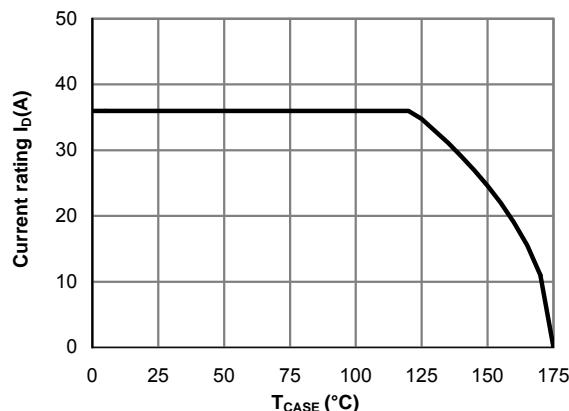
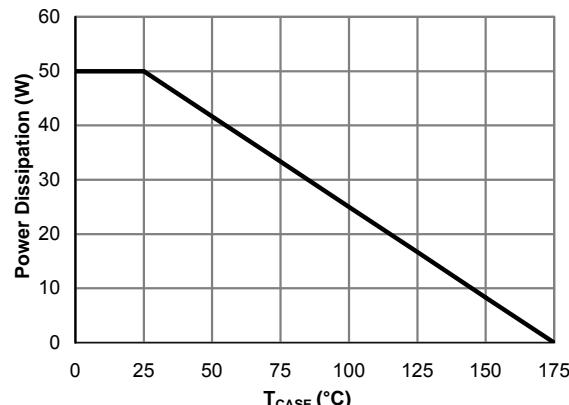
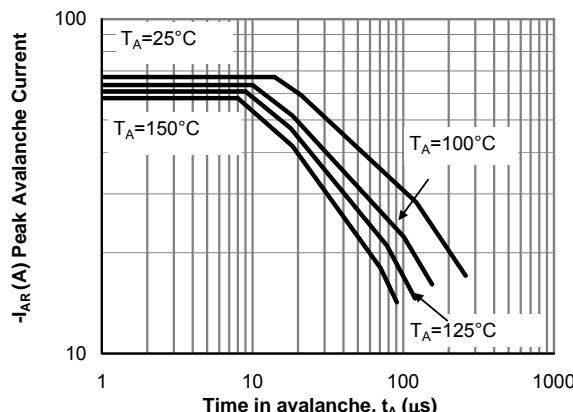
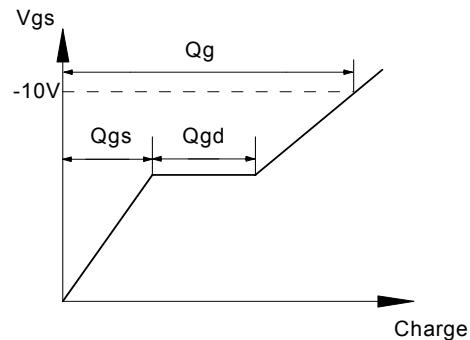
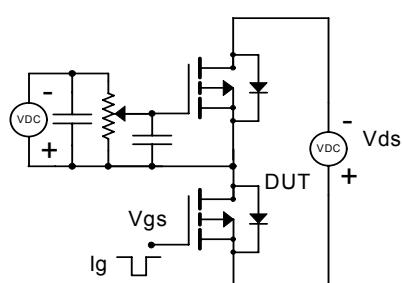


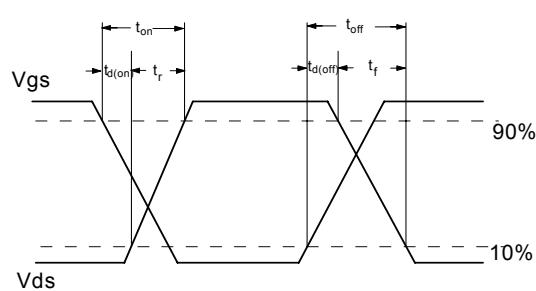
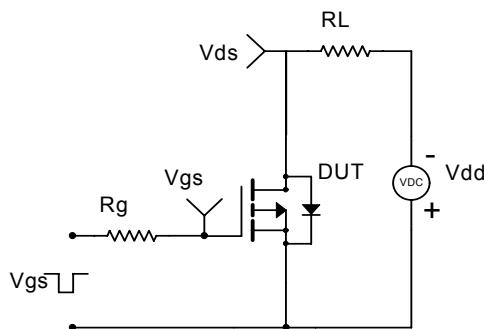
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**


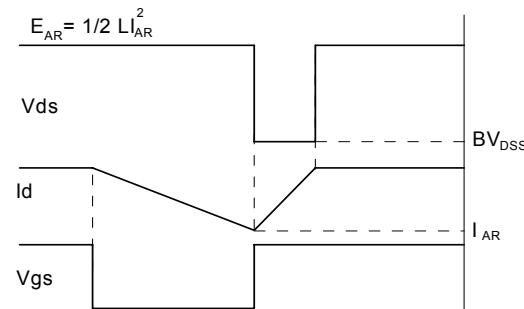
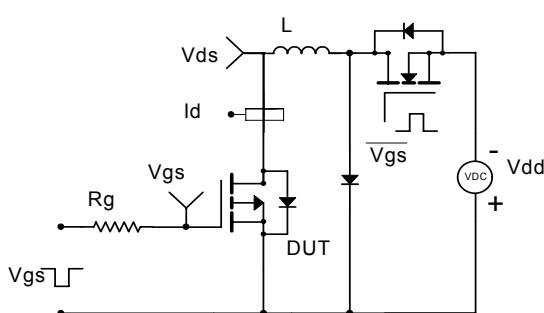
### Gate Charge Test Circuit & Waveform



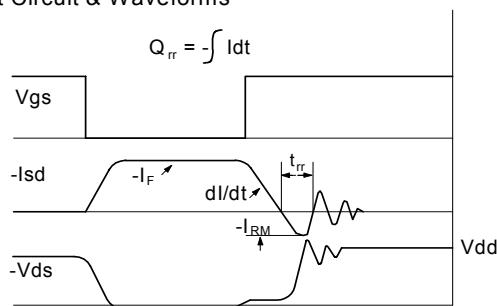
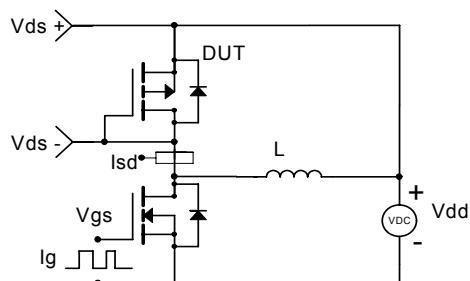
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### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



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